

Silicon Carbide (SiC) MOSFET – 80 mohm, 1200 V, M1, D2PAK-7L

NTBG080N120SC1

Features

- Typ. $R_{DS(on)} = 80 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q_{G(tot)} = 56 nC)
- Low Effective Output Capacitance (Typ. Coss = 79 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

Typical Applications

- UPS
- DC-DC Converter
- Boost Inverter

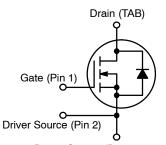
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V_{DSS}	1200	V	
Gate-to-Source Voltage	ge		V_{GS}	-15/+25	V
Recommended Operation Values of Gate-Source Voltage		T _C < 175°C	V_{GSop}	-5/+20	V
Continuous Drain Current (Note 1)	,		I _D	30	Α
Power Dissipation (Note 1)			P _D	179	W
Continuous Drain Current (Note 1)	Steady State T _C = 100°C		I _D	21	Α
Power Dissipation (Note 1)			P _D	89	W
Pulsed Drain Current (Note 2) T _C = 25°C		I _{DM}	110	Α	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	ç	
Source Current (Body Diode)		I _S	18	Α	
Single Pulse Drain-to-Source Avalanche Energy (I_L = 18.5 A_{pk} , L = 1 mH) (Note 3)		E _{AS}	171	mJ	
Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds		TL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

2. Repetitive rating, limited by max junction temperature.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
1200 V	110 mΩ @ 20 V	30 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

AYWWZZ NTBG 080120SC1

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

NTBG080120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTBG080N120SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

3. E_{AS} of 171 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 18.5 A, V_{DD} = 120 V, V_{GS} = 18 V.

Table 1. THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{ heta JC}$	0.84	°C/W
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	40	°C/W

Table 2. ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			-		-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	1200			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, refer to 25°C		0.5		V/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$			100	μΑ
		$V_{DS} = 1200 \text{ V}$ $T_{J} = 175^{\circ}\text{C}$			1	mA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +25/-15 V, V _{DS} = 0 V			±1	μΑ
ON CHARACTERISTICS (Note 2)			-		-	-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 5 \text{ mA}$	1.8	3	4.3	V
Recommended Gate Voltage	V_{GOP}		-5		+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 20 V, I _D = 20 A, T _J = 25°C		80	110	mΩ
		V _{GS} = 20 V, I _D = 20 A, T _J = 150°C		121		mΩ
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 20 A		11		S
CHARGES, CAPACITANCES & GATE RES	ISTANCE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz,		1154		pF
Output Capacitance	C _{OSS}	V _{DS} = 800 V		79		
Reverse Transfer Capacitance	C _{RSS}			7.9		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$		56		пC
Threshold Gate Charge	Q _{G(TH)}	I _D = 20 A		10		1
Gate-to-Source Charge	Q_{GS}			18		
Gate-to-Drain Charge	Q_{GD}			11		
Gate-Resistance	R_{G}	f = 1 MHz		1.2		Ω
SWITCHING CHARACTERISTICS	1					1
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$		12	22	ns
Rise Time	t _r	I_D = 20 A, R_G = 4.7 Ω , Inductive Load		12	22	
Turn-Off Delay Time	t _{d(OFF)}			21	34	
Fall Time	t _f			9	18	
Turn-On Switching Loss	E _{ON}			135		μJ
Turn-Off Switching Loss	E _{OFF}			46		1
Total Switching Loss	E _{TOT}			181		1
DRAIN-SOURCE DIODE CHARACTERIST	ics			•		
Continuous Drain-Source Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$			18	Α
Pulsed Drain–Source Diode Forward Current (Note 2)	I _{SDM}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$			110	Α
Forward Diode Voltage	V_{SD}	$V_{GS} = -5 \text{ V}, I_{SD} = 10 \text{ A}, T_{J} = 25^{\circ}\text{C}$	1	3.9	1	V

Table 2. ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise stated) (continued)

	1100 (.) =0	o amoso omisimos otatoa) (osimiasa	,			
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 20 \text{ A},$		16.2		ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 1000 A/μs		61.6		nC
Reverse Recovery Energy	E _{REC}			4.1		μJ
Peak Reverse Recovery Current	I _{RRM}			7.6		Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

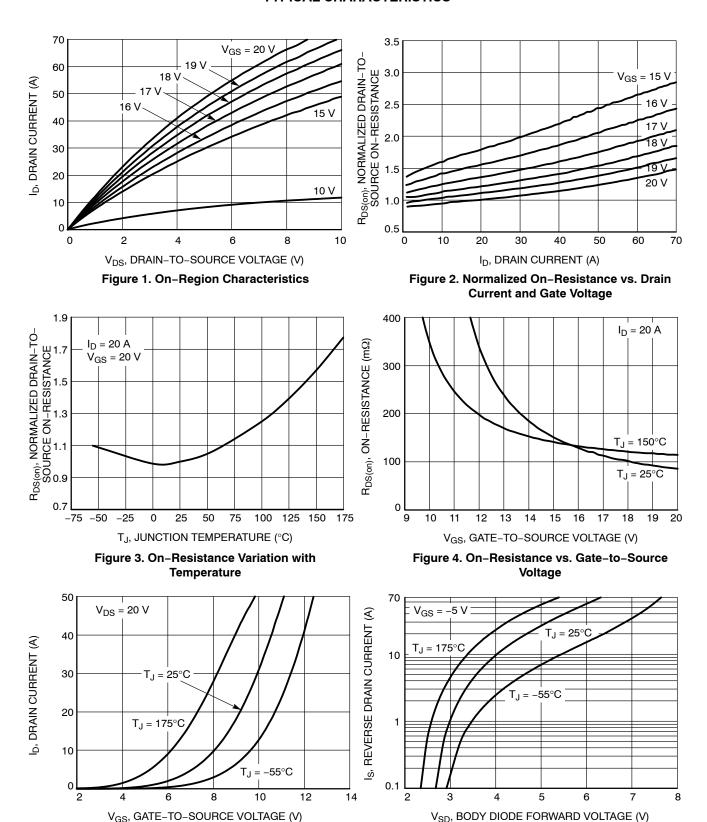


Figure 6. Diode Forward Voltage vs. Current

Figure 5. Transfer Characteristics

TYPICAL CHARACTERISTICS (continued)

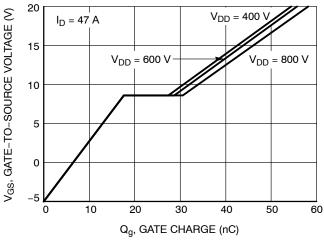


Figure 7. Gate-to-Source Voltage vs. Total Charge

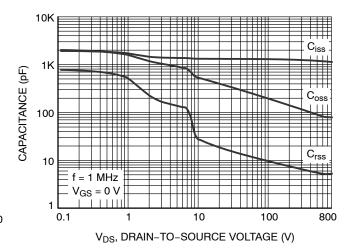


Figure 8. Capacitance vs. Drain-to-Source Voltage

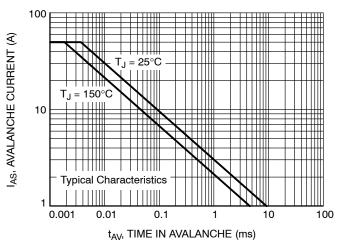


Figure 9. Unclamped Inductive Switching Capability

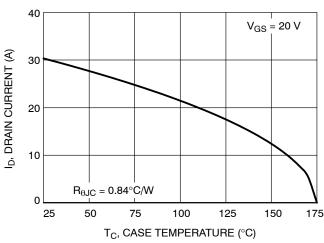


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

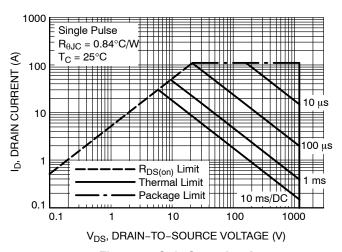


Figure 11. Safe Operating Area

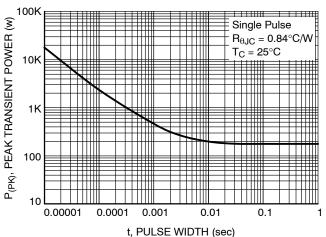


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

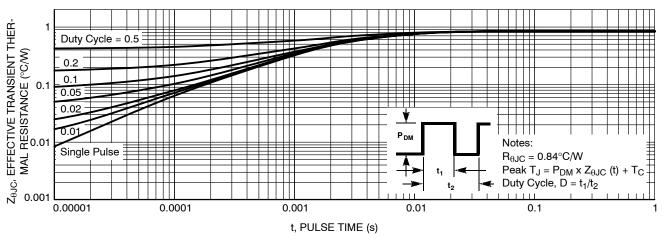


Figure 13. Junction-to-Case Transient Thermal Response Curve

D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

DATE 16 AUG 2019

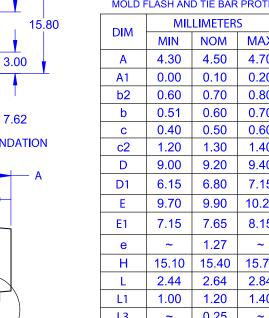
NOTES:

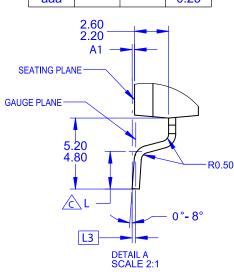
- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.

 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

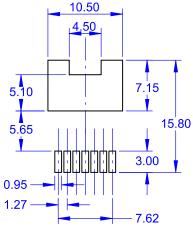
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	4.30	4.50	4.70			
A1	0.00	0.10	0.20			
b2	0.60	0.70	0.80			
b	0.51	0.60	0.70			
С	0.40	0.50	0.60			
c2	1.20	1.30	1.40			
D	9.00	9.20	9.40			
D1	6.15	6.80	7.15			
Е	9.70	9.90	10.20			
E1	7.15	7.65	8.15			
е	~	1.27	~			
Н	15.10	15.40	15.70			
L	2.44	2.64	2.84			
L1	1.00	1.20	1.40			
L3	~	0.25	~			
aaa	~	~	0.25			

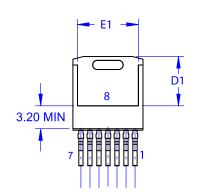


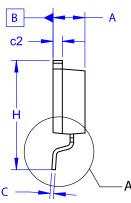


Α L1 D aaa | B | A |M



LAND PATTERN RECOMMENDATION





GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to

device data sneet for actual part marking.
Pb-Free indicator, "G" or microdot "■", may
or may not be present. Some products may
not follow the Generic Marking.
_

Electronic versions are uncontrolled except when accessed directly from the Document Repository. **DOCUMENT NUMBER:** 98AON84234G Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** D²PAK7 (TO-263-7L HV) **PAGE 1 OF 1**

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative